

Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

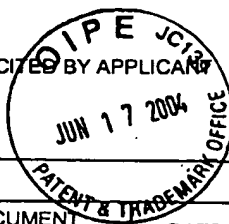
ATTY DOCKET NO.

250487US2

SERIAL NO.

10/803,991

LIST OF REFERENCES CITED BY APPLICANT



APPLICANT

Tomohiro NAKAJIMA, et al.

FILING DATE

March 19, 2004

GROUP

2872

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
AK	AA	2002/0195552	12/26/02	Ueda			
	AB	2002/0171878	11/21/02	Nakajima			
	AC	2002/0080428	06/27/02	Suzuki et al.			
	AD	6,509,995	01/21/03	Suzuki et al.			
	AE	6,621,512	09/16/03	Nakajima et al.			
	AF	6,686,946	02/03/04	Masuda et al.			
	AG	6,657,765	12/02/03	Hayashi et al.			
	AH	6,606,179	08/12/03	Suzuki et al.			
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AO					
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW		
	AX		
	AY		
	AZ		

☐ Additional References sheet(s) attached

Examiner

Date Considered

6/17/2005

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 250487US2		SERIAL NO. 10/803,991	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Tomohiro NAKAJIMA, et al.			
				FILING DATE March 19, 2004		GROUP 2572	
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
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	AI						
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	AK						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
<i>PK</i>	AL	3049606 (2000-180773)	06/05/2000	JAPAN (with English Abstract)			X
<i>PK</i>	AM	3078830 (4-131872)	08/21/2000	JAPAN (with English Abstract)			X
<i>PK</i>	AN	2002-148551	05/22/2002	JAPAN (with English Abstract)			X
<i>PK</i>	AO	11-64758	03/05/1999	JAPAN (with English Abstract)			X
<i>PK</i>	AP	64-52116	02/28/1989	JAPAN (with English Abstract)			X
<i>PK</i>	AQ	2-250020	10/05/1990	JAPAN (with English Abstract)			X
<i>PK</i>	AR	7-43627	02/14/1995	JAPAN (with English Abstract)			X
<i>PK</i>	AS	2001-296492	10/26/2001	JAPAN (with English Abstract)			X
<i>PK</i>	AT	9-179047	07/11/1997	JAPAN (with English Abstract)			X
<i>PK</i>	AU	2000-330049	11/30/2000	JAPAN (with English Abstract)			X
<i>PK</i>	AV	3222052 (9-189872)	10/22/2001	JAPAN (with English Abstract)			X
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner <i>J. MacKenzie</i>				Date Considered <i>10/03/2005</i>			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							